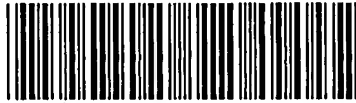


**Search Notes**

Application/Control No.

10/537,392

Examiner

Benny Lee

Applicant(s)/Patent under  
Reexamination

BARDELL ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
315	5,5.38, 5.39,5.51	11/30/2007	BTL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR